



AN 359

Advanced SiGe SIMS Analyses, As in SiGe

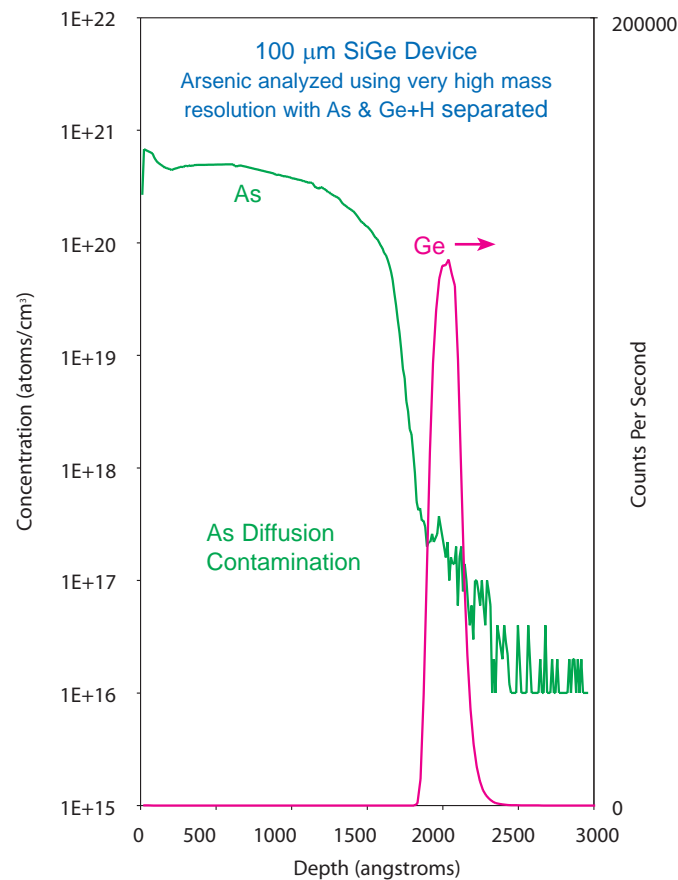
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## Discussion

As SiGe devices become more common, it becomes more vital to provide supporting SIMS measurements. One critical challenge is to provide good detection of As in SiGe while still maintaining good depth resolution in a small area device. Currently these two are mutually incompatible. Small area devices ( $< 100 \mu\text{m}$ ) create further complication. SiGe material vendors and device manufacturers would benefit from the solution to this problem.

A critical problem is ascertaining whether As contamination exists in the SiGe layer from the As doped poly-Si layer. High mass resolution (HMR) is essential to achieve low detection levels where molecular Ge+H interferes with atomic As in SiGe. A low primary beam energy is required for good depth resolution. A well-focused primary beam is required to measure a small device.

HMR as high as 11,000 was used to measure As in SiGe devices to provide detection levels in the range of  $\leq 1 \times 10^{16}$  at/cm<sup>3</sup>. The analysis was performed using low energy Cs (3 keV) to maintain good depth resolution. With As separated from Ge+H, As contamination and diffusion into the SiGe layer was detected.



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